

# P-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$ Typ.	I <sub>D</sub> (A) <sup>d</sup>	Q <sub>g</sub> (TYP.)		
-60	0.050 at V <sub>GS</sub> = -10 V	-6.5	10.1 nC		
	0.060 at V <sub>GS</sub> = -4.5 V	-5.1	10.1110		

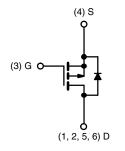
## **FEATURES**

- TrenchFET® power MOSFET
- 100 % R<sub>g</sub> and UIS tested



### **APPLICATIONS**

- Load switches
- DC/DC converter



P-Channel MOSFET

	_	TSOP Top Vie		_
T		1	6	
3 mm	П	2	5	Ш
	Ш	3	4	
<del></del>	<b> -</b>	<b>—</b> 2.85 m	m <b>—</b>	

ABSOLUTE MAXIMUM RATINGS (TA	= 25 °C, unless other	wise noted)		
PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	V <sub>DS</sub>	-60	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	V
	T <sub>C</sub> = 25 °C		-6.5	
Continuous Dusin Comment (T. 150 °C)	T <sub>C</sub> = 70 °C	] , [	-4.5	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	-3.8 <sup>a,b</sup>	
	T <sub>A</sub> = 70 °C		-3.1 <sup>a,b</sup>	
Pulsed Drain Current (t = 100 μs)		I <sub>DM</sub>	-20	A
	T <sub>C</sub> = 25 °C		-3.5	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	l <sub>s</sub>	-1.7 <sup>a,b</sup>	
Avalanche Current		I <sub>AS</sub>	-15	
Single-Pulse Avalanche Energy L = 0.1 mH		E <sub>AS</sub>	11.25	mJ
	T <sub>C</sub> = 25 °C		4.2	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C		2.7	14/
	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2 <sup>a,b</sup>	W
	T <sub>A</sub> = 70 °C	]	1.3 <sup>a,b</sup>	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C	

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum Junction-to-Ambient a,c	t ≤ 10 s	$R_{thJA}$	40	62.5	°C/W	
Maximum Junction-to-Foot	Steady State	$R_{thJF}$	25	30	C/ <b>V</b> V	

#### Notes

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under steady state conditions is 110 °C/W.
- d. Based on  $T_C$  = 25 °C.



PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static					l	I	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = -250 μA	-60	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L 050 A		-6.7	-		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = -250 μA	-	4.3	-	mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-	-0.5	-	-2V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA	
		V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V	-	-	-1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C	-	-	-5	μA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	-30	-	-	Α	
		V <sub>GS</sub> = -10 V, I <sub>D</sub> = -3.5 A	-	0.050	-	Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -2.8 A	-	0.060	-		
Forward Transconductance a	9 <sub>fs</sub>	$V_{DS} = -30 \text{ V}, I_D = -3.5 \text{ A}$	-	11	-	S	
Dynamic <sup>b</sup>				I.	l	L	
Input Capacitance	C <sub>iss</sub>		-	832	-	pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	88	-		
Reverse Transfer Capacitance	C <sub>rss</sub>		-	63	-		
Total Gate Charge	$Q_g$ $V_{DS} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -3.5 \text{ A}$	$V_{DS} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -3.5 \text{ A}$	-	20	30		
		-	10.1	15.2			
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = -30 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -3.5 \text{ A}$	-	3.3	-	nC	
Gate-Drain Charge	Q <sub>gd</sub>		-	3.9	-		
Gate Resistance	R <sub>g</sub>	f = 1 MHz	1.8	9	18	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>		-	8	16		
Rise Time	t <sub>r</sub>	$V_{DD} = -30 \text{ V}, R_1 = 10.7 \Omega$	-	6	12	1	
Turn-Off DelayTime	$t_{d(off)}$ $I_D \cong -2.8 \text{ A, } V_{GEN} = -10 \text{ V, F}$	$I_D \cong -2.8 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$	-	35	53		
Fall Time	t <sub>f</sub>		-	16	24		
Turn-On Delay Time	t <sub>d(on)</sub>		-	40	60	ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = -30 V, $R_L$ = 10.7 $\Omega$	-	28	42	1	
Turn-Off DelayTime			-	31	47	1	
Fall Time	t <sub>f</sub>		-	15	23	1	
Drain-Source Body Diode Characterist	ics			I.	l	·	
Continous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	-	-3.5		
Pulse Diode Forward Current (t = 100 µs)	I <sub>SM</sub>		-	-	-20	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = -2.8 A, V <sub>GS</sub> = 0 V	-	-0.85	-1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>		-	32	48	ns	
Body Diode Reverse Recovery Charge Q <sub>rr</sub>		I <sub>F</sub> = -2.8 A, dl/dt = 100 A/μs,	-	45	68	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	T <sub>J</sub> = 25 °C	-	24	-	ns	
Reverse Recovery Rise Time	t <sub>b</sub>		_	8	-		

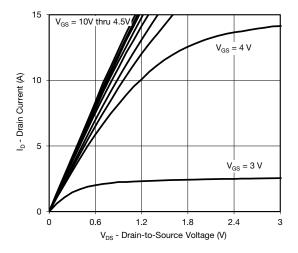
#### Notes

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

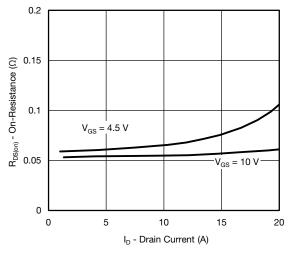
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



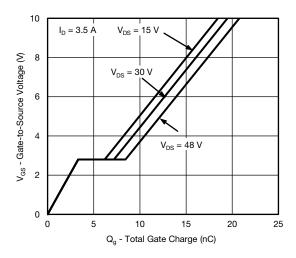
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



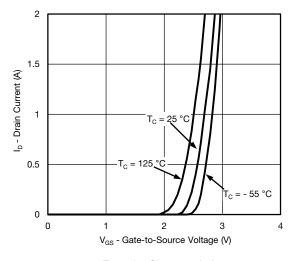
## **Output Characteristics**



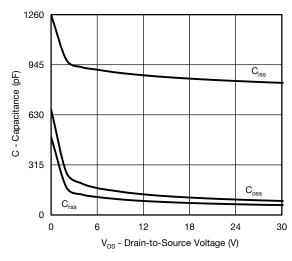
On-Resistance vs. Drain Current



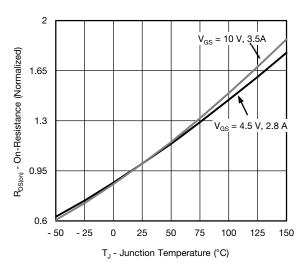
**Gate Charge** 



**Transfer Characteristics** 



Capacitance



On-Resistance vs. Junction Temperature

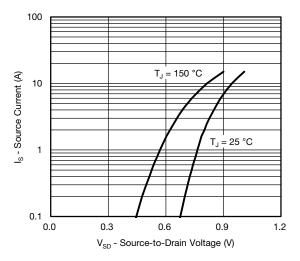


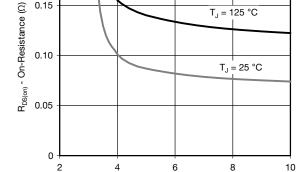
 $I_D = 3.5 A$ 

T<sub>J</sub> = 125 °C

 $T_J = 25$  °C

## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





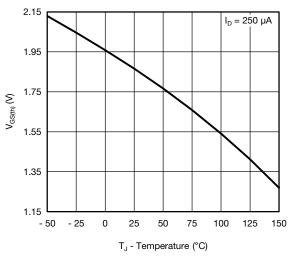
0.20

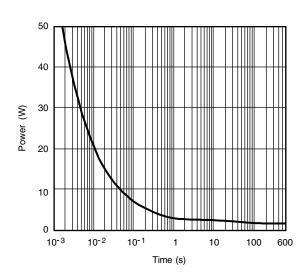
0.15

0.10

#### Source-Drain Diode Forward Voltage

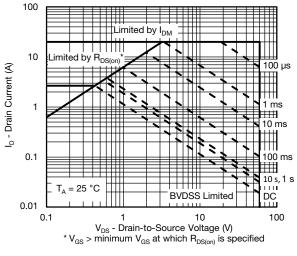






**Threshold Voltage** 

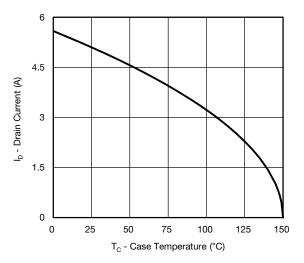
Single Pulse Power, Junction-to-Ambient



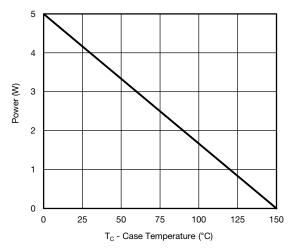
Safe Operating Area



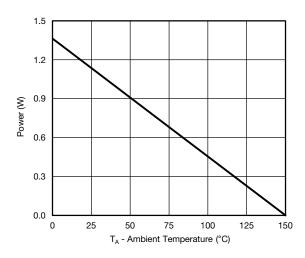
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



#### **Current Derating\***





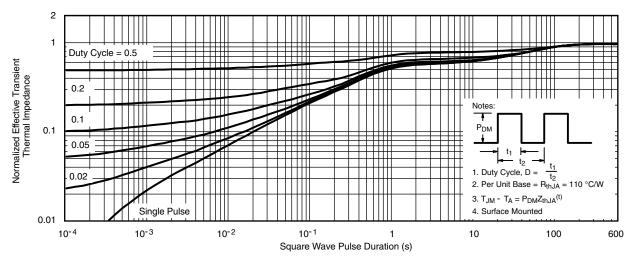


Power Derating, Junction-to-Ambient

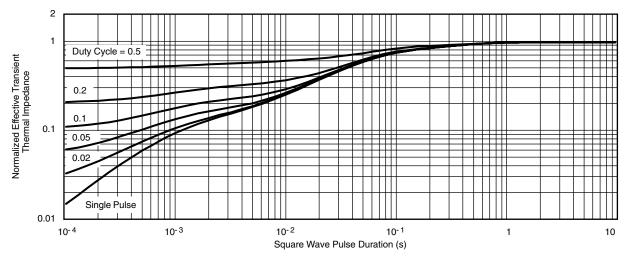
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J \text{ (max.)}} = 150 \,^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot



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